

## N-Ch 130V Fast Switching MOSFETs

- ★ Super Low Gate Charge
- ★ Green Device Available
- ★ Excellent Cdv/dt effect decline
- ★ Advanced high cell density Trench technology

## Product Summary



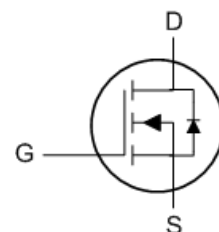
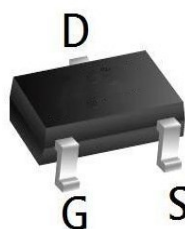
BVDSS	RDSON	ID
130V	165mΩ	2A

## Description

The XR2N13 is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The XR2N13 meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

## SOT23 Pin Configuration



## Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	130	V
$V_{GS}$	Gate-Source Voltage	$\pm 20$	V
$I_D @ T_A = 25^\circ\text{C}$	Continuous Drain Current	2	A
$I_D @ T_A = 70^\circ\text{C}$	Continuous Drain Current	---	A
$I_{DM}$	Pulsed Drain Current <sup>2</sup>	8	A
$P_D @ T_A = 25^\circ\text{C}$	Total Power Dissipation <sup>3</sup>	1.5	W
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
$T_J$	Operating Junction Temperature Range	-55 to 150	$^\circ\text{C}$

## Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction-ambient <sup>1</sup>	---	83.3	$^\circ\text{C/W}$
$R_{\theta JC}$	Thermal Resistance Junction-Case <sup>1</sup>	---	---	$^\circ\text{C/W}$

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Electrical Characteristics ( $T_J=25^\circ\text{C}$ , unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS}=0V$ , $I_D=250\mu A$	130	---	---	V
$\Delta BV_{DSS}/\Delta T_J$	$BV_{DSS}$ Temperature Coefficient	Reference to $25^\circ\text{C}$ , $I_D=1\text{mA}$	---	---	---	$V/^\circ\text{C}$
$R_{DS(ON)}$	Static Drain-Source On-Resistance <sup>2</sup>	$V_{GS}=10V$ , $I_D=1.5A$	---	165	200	$m\Omega$
		$V_{GS}=4.5V$ , $I_D=1A$	---	185	220	
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_D=250\mu A$	1.5	2	2.5	V
$\Delta V_{GS(th)}$	$V_{GS(th)}$ Temperature Coefficient		---	---	---	$mV/^\circ\text{C}$
$I_{DSS}$	Drain-Source Leakage Current	$V_{DS}=130V$ , $V_{GS}=0V$ , $T_J=25^\circ\text{C}$	---	---	1	$\mu A$
		$V_{DS}=130V$ , $V_{GS}=0V$ , $T_J=100^\circ\text{C}$	---	---	---	
$I_{GSS}$	Gate-Source Leakage Current	$V_{GS}=\pm 20V$ , $V_{DS}=0V$	---	---	$\pm 100$	nA
$g_{fs}$	Forward Transconductance	$V_{DS}=70V$ , $I_D=2A$	---	---	---	S
$R_g$	Gate Resistance	$V_{DS}=0V$ , $V_{GS}=0V$ , $f=1\text{MHz}$	---	---	---	$\Omega$
$Q_g$	Total Gate Charge	$V_{DS}=70V$ , $V_{GS}=10V$ , $I_D=2A$	---	2.66	---	nC
$Q_{gs}$	Gate-Source Charge		---	0.63	---	
$Q_{gd}$	Gate-Drain Charge		---	0.57	---	
$T_{d(on)}$	Turn-On Delay Time	$V_{GS}=10V$ , $V_{DD}=70V$ , $R_G=3\Omega$ , $I_D=2A$	---	4	---	ns
$T_r$	Rise Time		---	6	---	
$T_{d(off)}$	Turn-Off Delay Time		---	11	---	
$T_f$	Fall Time		---	3	---	
$C_{iss}$	Input Capacitance	$V_{DS}=70V$ , $V_{GS}=0V$ , $f=1\text{MHz}$	---	126	---	pF
$C_{oss}$	Output Capacitance		---	17.8	---	
$C_{rss}$	Reverse Transfer Capacitance		---	26	---	

## Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$I_S$	Continuous Source Current <sup>1,4</sup>	$V_G=V_D=0V$ , Force Current	---	---	2	A
$V_{SD}$	Diode Forward Voltage <sup>2</sup>	$V_{GS}=0V$ , $I_S=1A$ , $T_J=25^\circ\text{C}$	---	---	1.2	V
$t_{rr}$	Reverse Recovery Time	$I_F=2A$ , $di/dt=100A/\mu s$ , $T_J=25^\circ\text{C}$	---	24	---	nS
$Q_{rr}$	Reverse Recovery Charge		---	100	---	nC

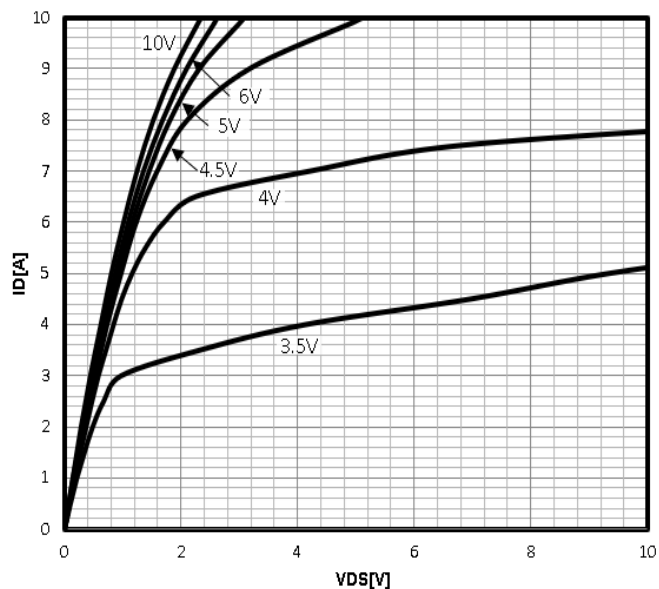
## Notes:

1. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=150^\circ\text{C}$ .
2. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
3. Pulse Test: Pulse width $\leq 300\mu s$ , duty cycle $\leq 2\%$ .
4. This value is guaranteed by design hence it is not included in the production test.

### Characteristics Curve:

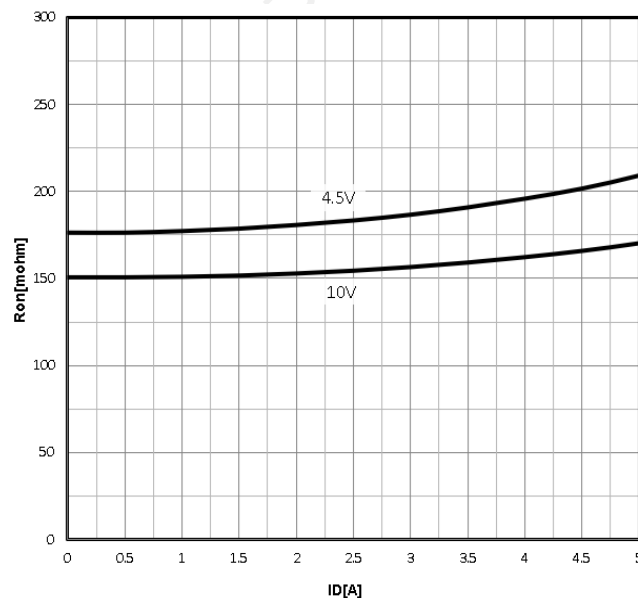
Typ. output characteristics

$$I_D = f(V_{DS})$$



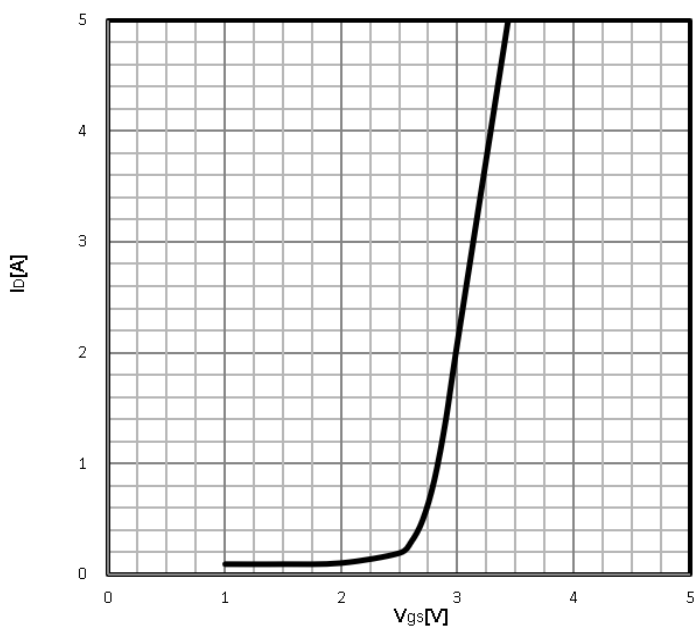
Typ. drain-source on resistance

$$R_{DS(on)} = f(I_D)$$



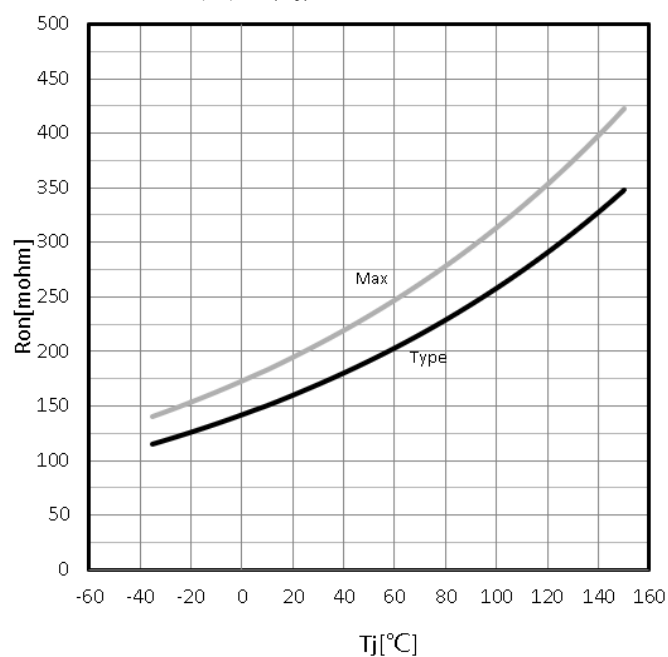
Typ. transfer characteristics

$$I_D = f(V_{GS})$$



Drain-source on-state resistance

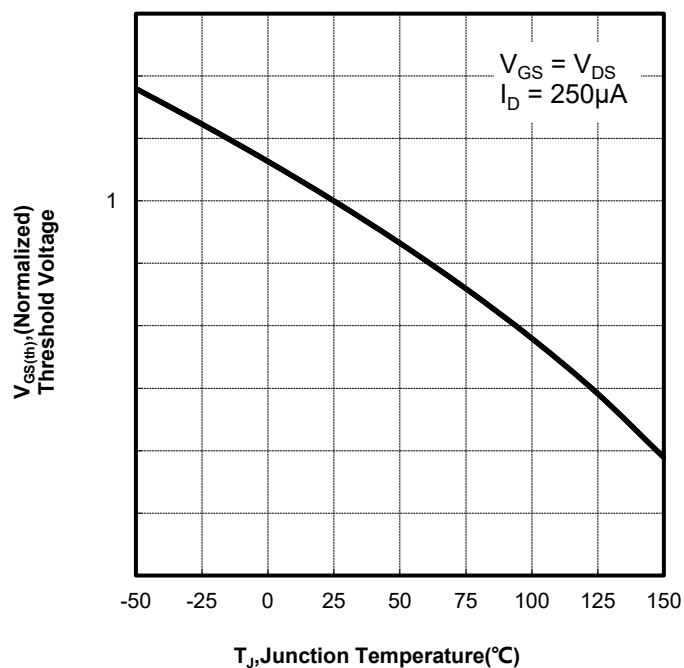
$$R_{DS(on)} = f(T_j); I_D = 2A; V_{GS} = 10V$$



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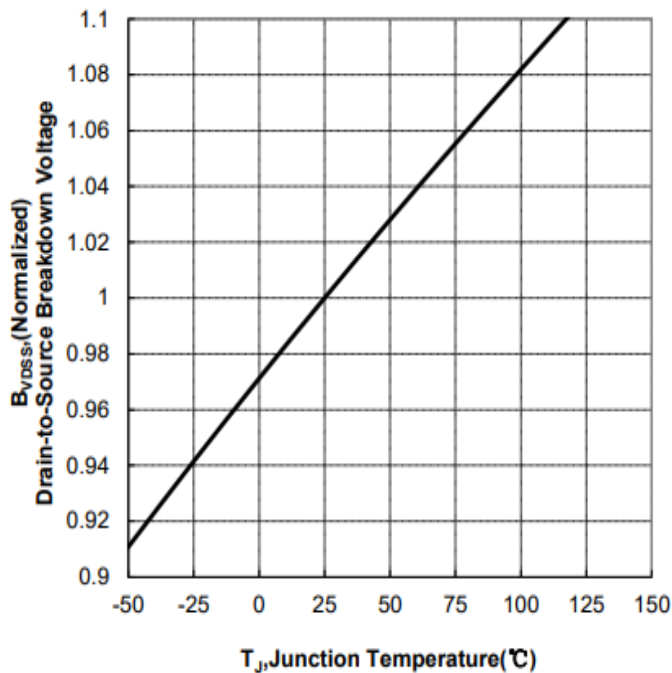
### Gate Threshold Voltage

$$V_{TH}=f(T_j); I_D=250\mu A$$



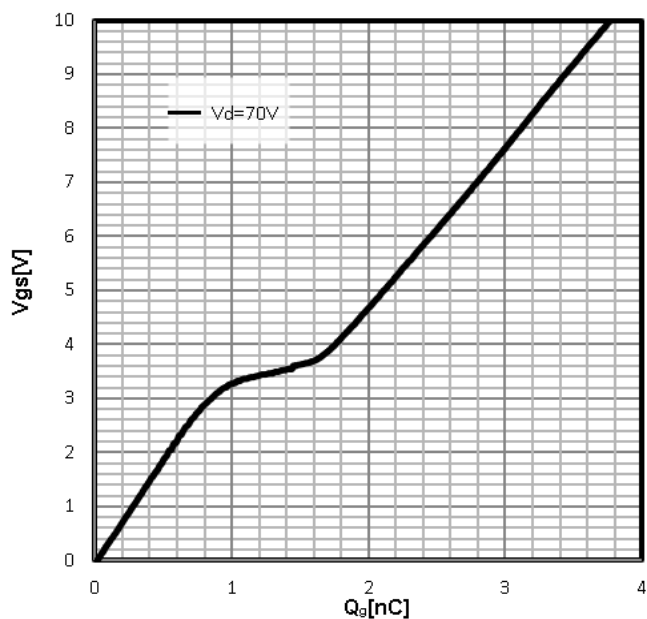
### Drain-source breakdown voltage

$$V_{BR(DSS)}=f(T_j); I_D=250\mu A$$



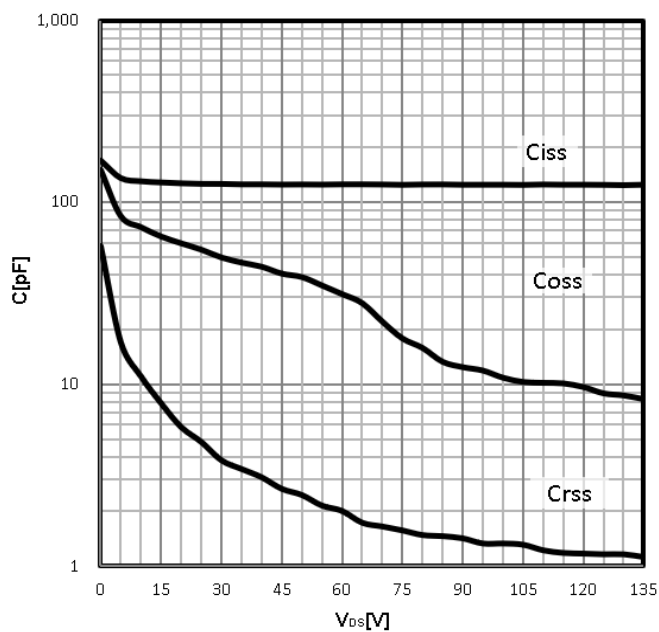
### Typ. gate charge

$$V_{GS}=f(Q_g); I_D=2A$$



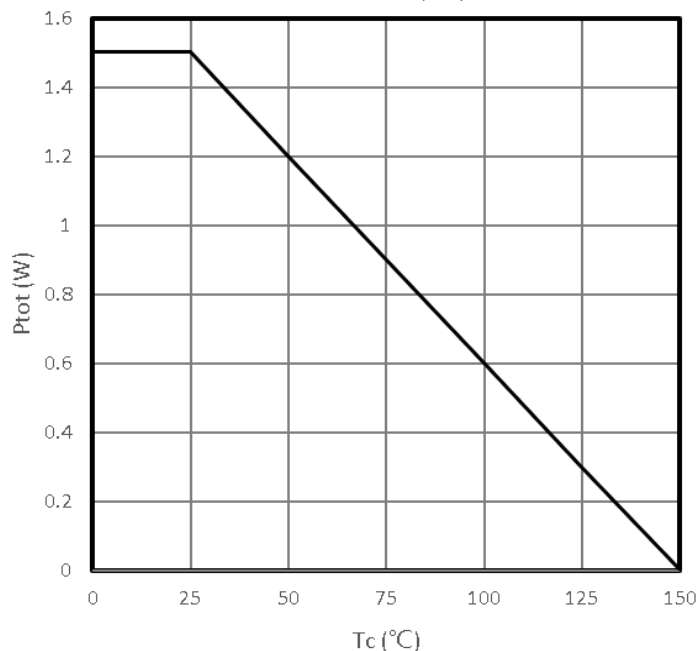
### Typ. capacitances

$$C=f(V_{DS}); V_{GS}=0V; f=1MHz$$



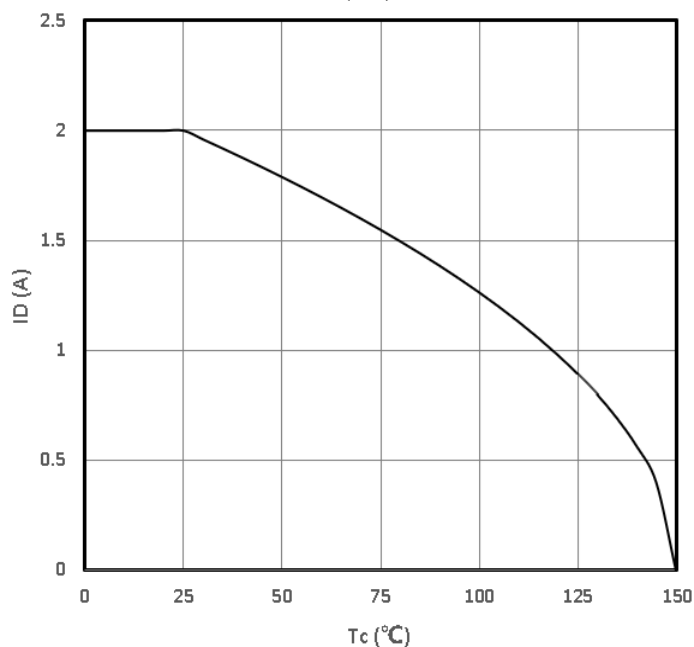
### Power Dissipation

$$P_{tot}=f(T_C)$$



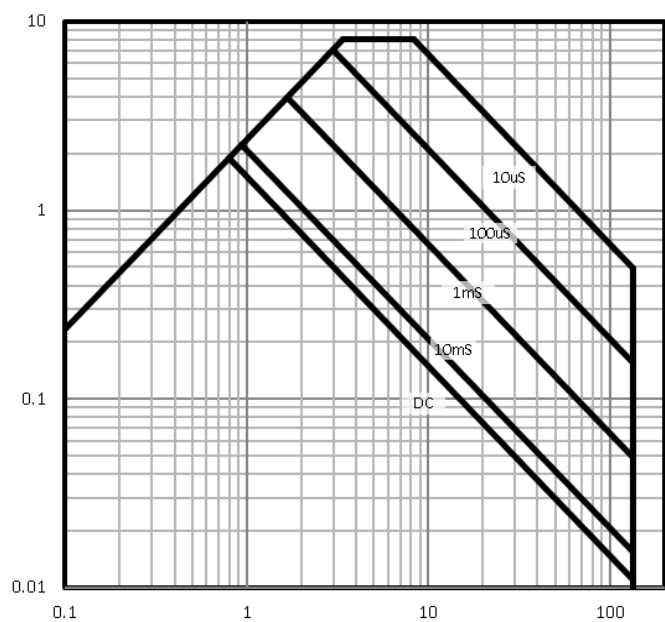
### Maximum Drain Current

$$I_D=f(T_C)$$



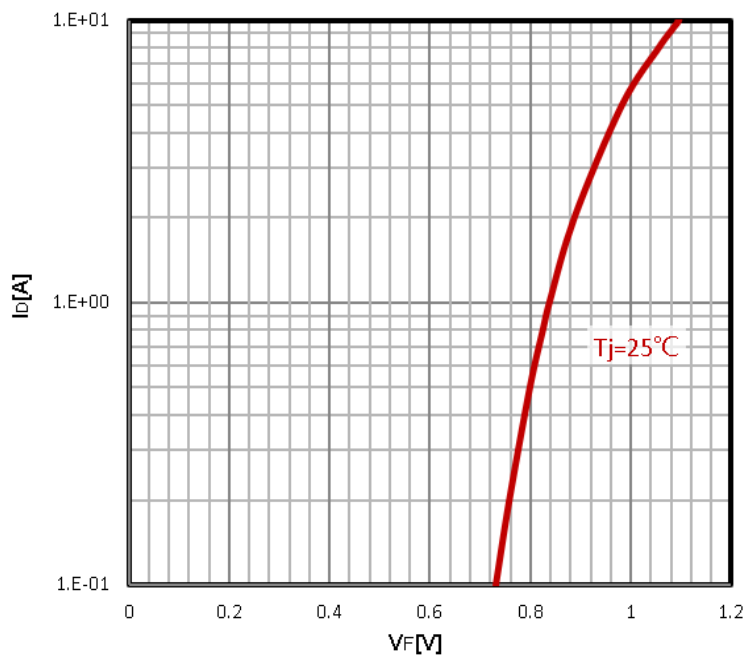
### Safe operating area

$$I_D=f(V_{DS})$$



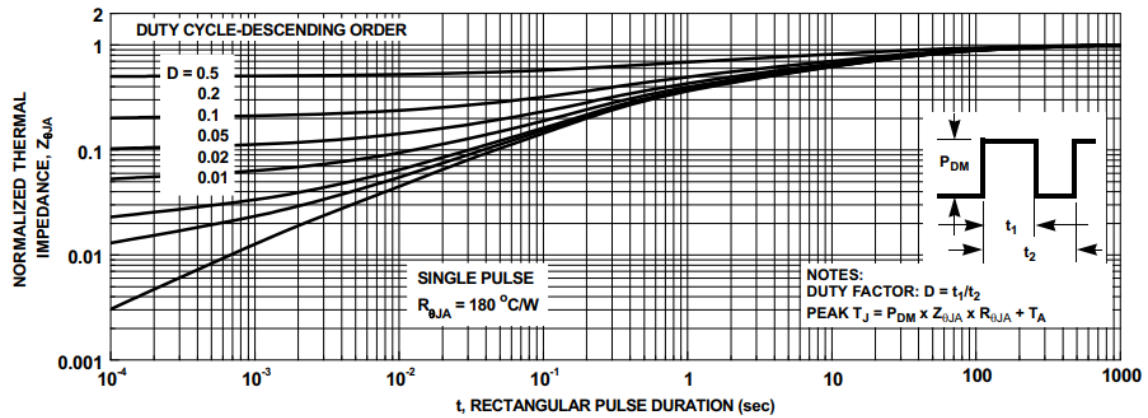
### Body Diode Forward Voltage Variation

$$I_F=f(V_{GS})$$

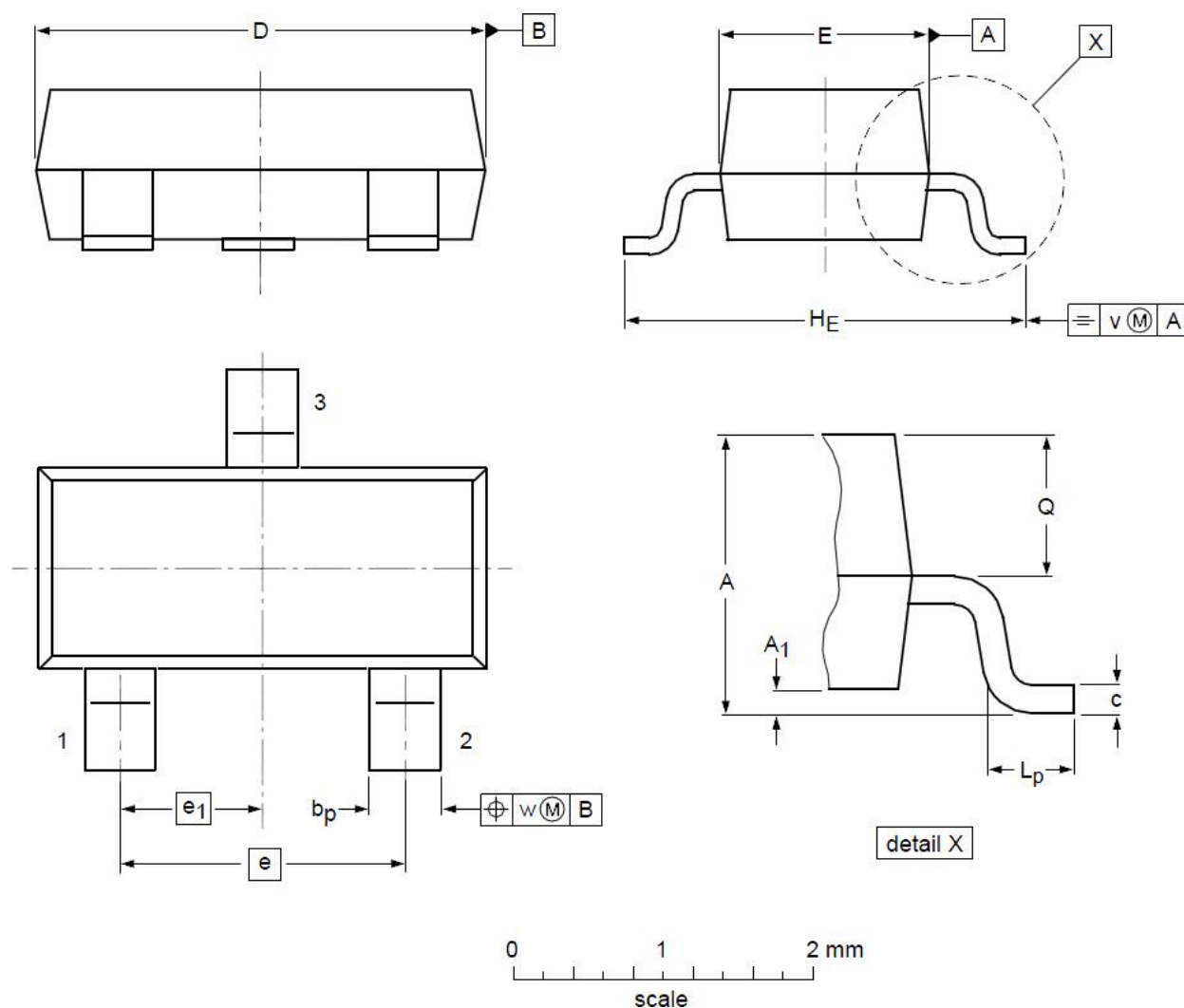


### Max. transient thermal impedance

$$Z_{thJC}=f(t_p)$$



### SOT23 Mechanical Data



### DIMENSIONS ( unit : mm )

Symbol	Min	Typ	Max	Symbol	Min	Typ	Max
<b>A</b>	0.90	1.01	1.15	<b>A<sub>1</sub></b>	0.01	0.05	0.10
<b>b<sub>p</sub></b>	0.30	0.42	0.50	<b>c</b>	0.08	0.13	0.15
<b>D</b>	2.80	2.92	3.00	<b>E</b>	1.20	1.33	1.40
<b>e</b>	--	1.90	--	<b>e<sub>1</sub></b>	--	0.95	--
<b>H<sub>E</sub></b>	2.25	2.40	2.55	<b>L<sub>p</sub></b>	0.30	0.42	0.50
<b>Q</b>	0.45	0.49	0.55	<b>v</b>	--	0.20	--
<b>w</b>	--	0.10	--				